Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/767,499	NICHTAWITZ ET AL.	
Examiner	Art Unit	

Devin Hanan

3745

	SEARCHED			
Class	Subclass	Date	Examiner	
415	151,155			
	160-166			
	186			
	208.4			
	209.3			
			" -	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAR)
	DATE	EXMR
consulted Ninh Nguyen on class 415 and 416	5/18/2005	
consulted Chris Verdier on class 415 and 416	5/25/2005	DH
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